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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: S. WAKASHIRO et al.

Group Art Unit: 2877

Serial No : 10/761,230 (Division of 09/407,855)

Examiner: Not Assigned

Filed: January 22, 2004 Confirmation No.: 2038

: TARGET FOR PHOTOGRAMMETRIC ANALYTICAL MEASUREMENT

SYSTEM

PETITION TO CHANGE ORDER OF INVENTORS PURSUANT TO 37 C.F.R. § 1.182

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

For

Applicants note that the order of the inventors named in above-captioned U.S. Patent Application currently appears on the Official Filing Receipt as follows:

Shigeru WAKASHIRO Atsumi KANEKO Masami SHIRAI Kiyoshi YAMAMOTO

In accordance with 37 C.F.R. § 1.182, Applicants hereby request that the order of the named inventors be changed to the following:

Masami SHIRAI Atsumi KANEKO Kiyoshi YAMAMOTO Shigeru WAKASHIRO

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P24705.A03

Pursuant to 37 C.F.R. § 1.17(h), Applicants enclose herewith a check for the petition fee, in the amount of \$130.00.

If there should be any questions, the Examiner is invited to contact the undersigned at the telephone number listed below.

Respectfully submitted, Shigeru WAKASHIRO

Bruce H. Bernstein

Reg. No. 29,027

June 22, 2004 GREENBLUM & BERNSTEIN, P.L.C. 1950 Roland Clarke Place Reston, VA 20191 (703) 716-1191